



IPW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Rinze BENEDICTUS et al.

Serial No.: 10/821,184

Filed: April 9, 2004

TITLE: AN Al-Zn-Mg-Cu ALLOY WITH IMPROVED DAMAGE TOLERANCE-STRENGTH COMBINATION PROPERTIES

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to Rules 56 and 98, Applicants hereby call the attention of the Patent Office to the reference listed on the attached Form PTO 1449.

Applicants present this reference so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rule 104. Applicants respectfully request that this reference be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom.

Date: July 26, 2005

APV/mtw

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FORM PTO-1449 U.S. Department of Commerce  
(Rev. 4/92) Patent and Trademark Office

ATTY. DOCKET NO.  
APV31628A

SERIAL NO.  
10/821,184

INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT

(Use several sheets if necessary)

APPLICANT  
Rinze BENEDICTUS et al.

FILING DATE  
April 9, 2004

GROUP

## U.S. PATENT DOCUMENTS

[illegible]

## FOREIGN PATENT DOCUMENTS

[illegible]

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

		Machine translation of excerpts of published PCT patent application no. WO95/26420, published October 1995.
		US Published Patent Application No. 2004/0109787A1, (Ser. No. 10,725,501), Haszler et al., filed December 3, 2003, published June 10, 2004.

EXAMINER

DATE CONSIDERED

**EXAMINER:** Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.